


<b>Search Notes</b>  	<b>Application/Control No.</b>  10812075	<b>Applicant(s)/Patent Under Reexamination</b>  SEKIGUCHI ET AL.
	<b>Examiner</b>  Jaisle, Cecilia M	<b>Art Unit</b>  1624

### SEARCHED

Class	Subclass	Date	Examiner
514	275	6/24/2007	Cecilia Jaisle
544	332, 330	6/25/2007	Cecilia Jaisle
544	310, 312	7/9/2007	Cecilia Jaisle
514	275, 235.8	10/29/2007	Cecilia Jaisle
544	310, 312, 122, 123	10/29/2007	Cecilia Jaisle
514	235.8, 275	4/28/2008	C. Jaisle
544	310, 312, 122, 123	4/28/2008	C. Jaisle
514	235.8, 275	5/27/2008	C. Jaisle
544	310, 312, 122, 123	5/27/2008	C. Jaisle

### SEARCH NOTES

Search Notes	Date	Examiner
STN search and Inventor Names searched by STIC	6/24/2007	Cecilia Jaisle

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
514	275	10/29/2007	Cecilia Jaisle
544	310, 312	10/29/2007	Cecilia Jaisle